

**Search Notes**

Application/Control No.

10/755,853

Examiner

Peter Coughlan

Applicant(s)/Patent under  
Reexamination

SPOONER ET AL.

Art Unit

2129

**SEARCHED**

Class	Subclass	Date	Examiner
700	1	3/10/2006	PDC
700	90	3/10/2006	PDC
706	1	3/10/2006	PDC
706	15	3/10/2006	PDC
706	45	3/10/2006	PDC
716	20	3/10/2006	PDC
600	443	3/10/2006	PDC
382	254	3/10/2006	PDC
395	500	3/10/2006	PDC
345	442	3/10/2006	PDC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East--numerical analysis, sphere, circle, error factor/tolerance, padding, parant space, trunk, child space, leaf,	3/10/2006	PDC
East--II--spatial location, object, goal, reslut, identifying	3/10/2006	PDC
Inventors Christopher Spooner Richard Spooner	3/10/2006	PDC
IEEE--classification, data mining, search (rescue), numercal analysis, padding, error (factor), tolerance of error.	3/10/2006	PDC
Dogpile- Christopher Spooner Richard Spooner	3/10/2006	PDC